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1961

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I.

I.

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II.

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III.

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IV.

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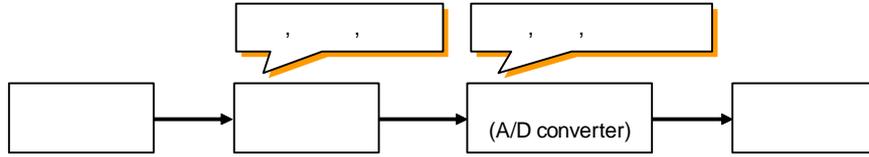
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* ETRI /
** ETRI /

02-07



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	(PD)
	(CCD , MOS)
/	
/	
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	- :가 - : - :
	- : - : DNA, Lab, - : - :
	- MOEMS : - RF - :
가	- : - : - : - :
	- : - :

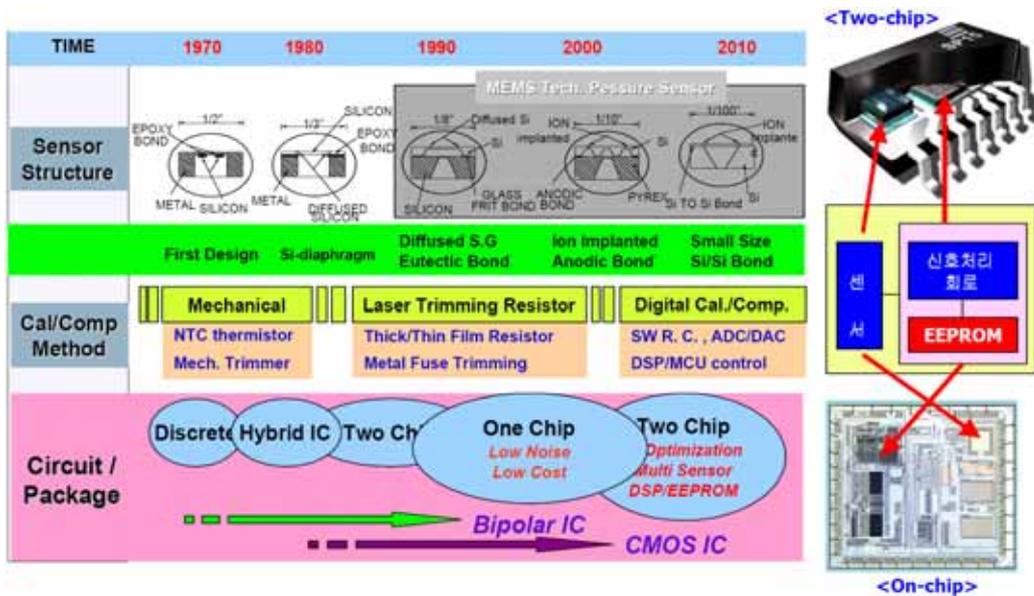
가

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II.

가 . 1950
 Bell Technology Lab
 Honeywell, Westinghouse
 가 . 1970
 1990 가
 , 1 1
 가 80 1 가



(2)

MEMS(Micro Electro Mechanical System)

MEMS

가

(2) MEMS

- 1950~1960 Discovery Period
 - 1954: Smith discovers piezoresistivity at Bell Labs
 - 1958: Discrete silicon strain gages commercially available
- 1960~1970 Commercialization and Market Development
 - 1961: Integration of strain gages into silicon diaphragm(Kulite)
 - 1966: Mechanically milled cavity introduced(Honeywell)
 - 1970: Isotropic micromachined window introduced(Kulite)
 - 1970: First piezoresistive acceleration sensors developed(Kulite)
- 1970~1980 Cost Reduction and Application Expansion
 - 1971: Sensors employing anodic bonding introduced(Kulite)
 - 1974: First high volumn hybrid sensor(National Semiconductor)
 - 1976: Anisotropic micromachined windows introduced(Kulite)
 - 1976: First under -hood automotive silicon sensor(Honeywell)
 - 1977: First silicon capacitive pressure sensor demonstrated(Stanford Univ.)
 - 1978: Bossed silicon diaphragms introduced(Endevco)
 - 1979: Passive on chip temperature compensation(Kulite)
 - 1979: Ion implantation of strain gages(Honeywell)
- 1980~1990 Micromachining and Rapid Market Growth
 - 1982: First disposable medical transducer(Foxboro/ICT, Honeywell)
 - 1982: Active on chip signal conditioning(Honeywell)
 - 1985: Polysilicon diaphragm sensor by additive process(Wisconsin Univ.)
 - 1987: Si-Si and Si-SiO₂ lamination implemented into sensor designs(NovaSensor)
 - 1988: SFB based acceleration sensor with 1000:1 overload protection(NovaSensor)
 - 1990: Introduction of SenStable: new superstable piezoresistive process/design (NovaSensor)

MEMS

< 3> MEMS

	Discovery	Evolution	Application & Expansion	Full Commercialization
Pressure Sensors	1954-1960	1960-1975	1975-1990	1990-Present
Accelerometers	1974-1985	1985-1990	1990-1998	1998
Gas Sensors	1986-1994	1994-1998	1998-2005	2005
Valves	1980-1988	1988-1996	1996-2002	2002
Nozzles	1972-1984	1984-1990	1990-1998	1998
Photonics/displays	1980-1994	1986-1998	1998-2004	2004
Bio/Chemicals Sensors	1980-1994	1994-1999	1999-2004	2004
RF Switches	1994-1998	1998-2001	2001-2005	2005
Rate Sensors	1982-1990	1990-1996	1996-2002	2002
Micro relays	1977-1982	1993-1998	1998-2006	2006

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	02	03	04	05
	1580	1640	1690	1740
	3670	3720	3780	3840
	4040	4340	4940	4940
가	1400	1610	2110	2110
	284	297	305	315
	2530	2740	2950	3180
	2790	2940	3300	3300
	560	590	630	670
	1160	1210	1320	1450
	1030	1100	1170	1240
	2270	2460	2630	2810
	186	190	194	199
	520	540	560	580
	189	200	212	223
가	2200	2380	2560	2740
	268	285	305	320
	24677	26242	27906	29657

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III.

MEMS 20

MEMS 가

가

NSF(National Science Foundation)

DARPA(Defence Advanced Research Project Agency), NASA, DOE(Department of Energy)

MEMS

MEMS

MEMS

가

Corning, Honeywell,

Xactix, Xerox 5

MEMS

'MEMS Industry

Group(MEMS-IG)'

, MEMS

2000

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가

가 MEMS

가

RF

가

MEMS

1994

NEXUS

. NEXUS

EC Europractive IST

8

MEMS

R&D

MEMSOI

MEMSOI

1991

Micromachine Project(1991~2000 , 10 250)

가 가

MMC()

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 based MEMS () 가 MEMS .
 MEMS 가 , Lithography - Mechatronics 가 가
 , 80 가
 MEMS 가 , 2000 10 PDA
 2000 MEMS LG 가 ,
 MEMS .
 가 , , / , 가 가 가
 Nano/MEMS 가 가 MEMS
 가 가 .

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				, Si, ,
				(PtRH - Pt, NiCr - Ni)
			가	
	/	pn PZT +	PI - DMOS	(Ni - Cr, Fe - Ni) (, Ni,) (PTZ, ZnO, , BaTiO3, LiNbO3) (, ZnO + Si) (Si, Ge) (Si, Ge) (Si, Ge, GeP, InSb, GaAs) [PVDF, P(VDF/TrFE), P(VDF/TFE), P(VDCN/VAC)] (ZnO + MOSFET) (PZT)

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LVDT

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가

가

가

3.

가 가

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02-07

가 가

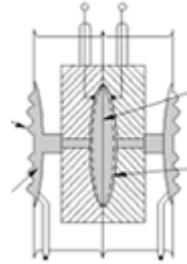
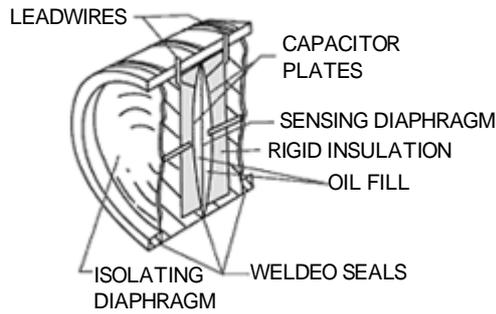
가 Si

SOS(Silicon On Sapphire)

SOS

가

(3)



(3)

4.

1961

가

Honeywell

가

1983

1988

Nova Sensor

(batch process)

2002

가

(MAP)

가

(4 ())

0.65×0.65mm

150mm

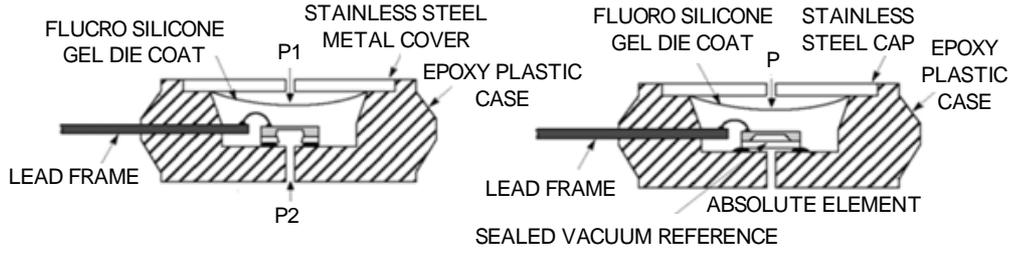
24,000

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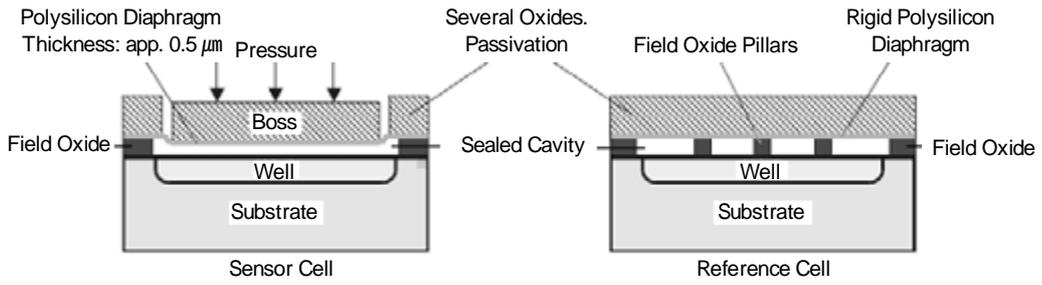
() MPXY8000 Series

가

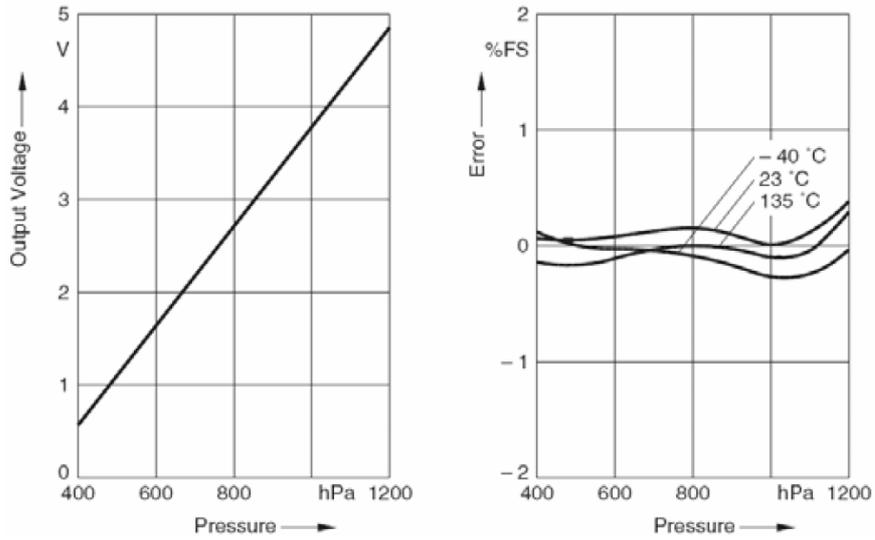
(Reference Cell) (14)



(5)



(6)



(7)

